

Notice of References Cited	Application/Control No. 10/521,287		Applicant(s)/Patent Under Reexamination SUTOH ET AL.	
	Examiner ROBERT LOEWE		Art Unit 1796	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,940,112 A	07-1990	O'Neill, Justin T.	181/290
*	B	US-5,294,487 A	03-1994	Ohashi et al.	428/308.4
*	C	US-5,357,007 A	10-1994	Wengrovius et al.	525/478
*	D	US-5,503,927 A	04-1996	Ragland et al.	428/353
*	E	US-5,658,629 A	08-1997	Delcuve et al.	428/41.3
*	F	US-5,993,590 A	11-1999	Krotseng, Kathryn G.	156/230
*	G	US-6,036,997 A	03-2000	Ragland et al.	427/208.4
*	H	US-6,531,643 B2	03-2003	Suzuki, Sachiyo	604/381
*	I	US-2003/0224183 A1	12-2003	Warburton-Pitt, Stephen	428/447
*	J	US-2004/0265599 A1	12-2004	Ushio et al.	428/447
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.